Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/773,366	SAITO ET AL.		
Examiner	Art Unit	_	
John S. Chu	1752		

	SEAR	RCHED			
Class	Subclass	Date	Examiner		
430	157	q (2000	J22		
430	171	١			
430	182				
		-			

INT	ITERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
	<u></u>				

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
		DATE	EXMR	
EAST SEARCH IN FILE		q (20+G	ger	
·				
, .				
ı				